Application/Control No. Applicant(s)/Patent Under Reexamination 10/507,116 FUKUZUMI ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1 John P. Sheehan 1742 **U.S. PATENT DOCUMENTS** Document Number Date Classification Name Country Code-Number-Kind Code MM-YYYY US-2005/0098238 A1 05-2005 148/302 Morimoto et al. Α * US-2004/0079449 A1 04-2004 Kanekiyo et al. 148/302 В US-С US-D

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